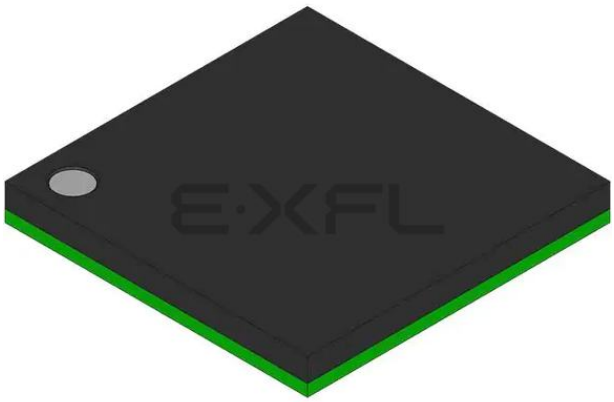

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	AVR
Core Size	32-Bit Single-Core
Speed	66MHz
Connectivity	EBI/EMI, I²C, IrDA, Memory Card, SPI, SSC, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, POR, WDT
Number of I/O	88
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	128K x 8
Voltage - Supply (Vcc/Vdd)	1.75V ~ 3.6V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-VFBGA
Supplier Device Package	100-VFBGA (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/atmel/at32uc3a4128-c1ut

  - Support for SPI and LIN
  - Optionnal support for IrDA, ISO7816, Hardware Handshaking, RS485 interfaces and Modem Line
- Two Master/Slave Serial Peripheral Interfaces (SPI) with Chip Select Signals
- One Synchronous Serial Protocol Controller
  - Supports I2S and Generic Frame-Based Protocols
- Two Master/Slave Two-Wire Interface (TWI), 400 kbit/s I2C-compatible
- 16-bit Stereo Audio Bitstream
  - Sample Rate Up to 50 KHz
- QTouch® Library Support
  - Capacitive Touch Buttons, Sliders, and Wheels
  - QTouch and QMatrix Acquisition
- On-Chip Debug System (JTAG interface)
  - Nexus Class 2+, Runtime Control, Non-Intrusive Data and Program Trace
- 110 General Purpose Input/Output (GPIOs)
  - Standard or High Speed mode
  - Toggle capability: up to 84 MHz
- Packages
  - 144-ball TFBGA, 11x11 mm, pitch 0.8 mm
  - 144-pin LQFP, 22x22 mm, pitch 0.5 mm
  - 100-ball VFBGA, 7x7 mm, pitch 0.65 mm
- Single 3.3 V Power Supply

3. Package and Pinout

3.1 Package

The device pins are multiplexed with peripheral functions as described in the Peripheral Multiplexing on I/O Line section.

Figure 3-1. TFBGA144 Pinout (top view)

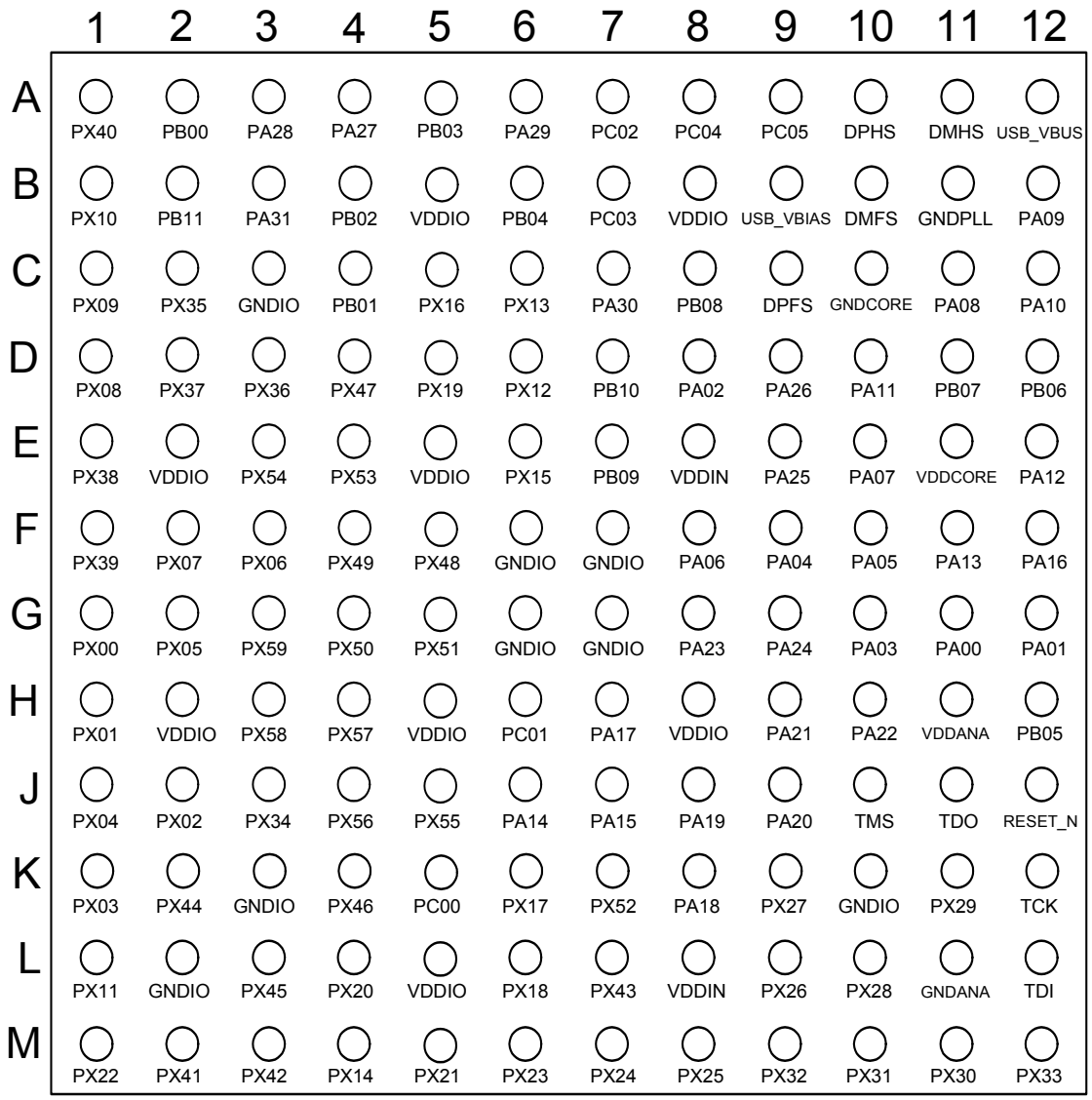
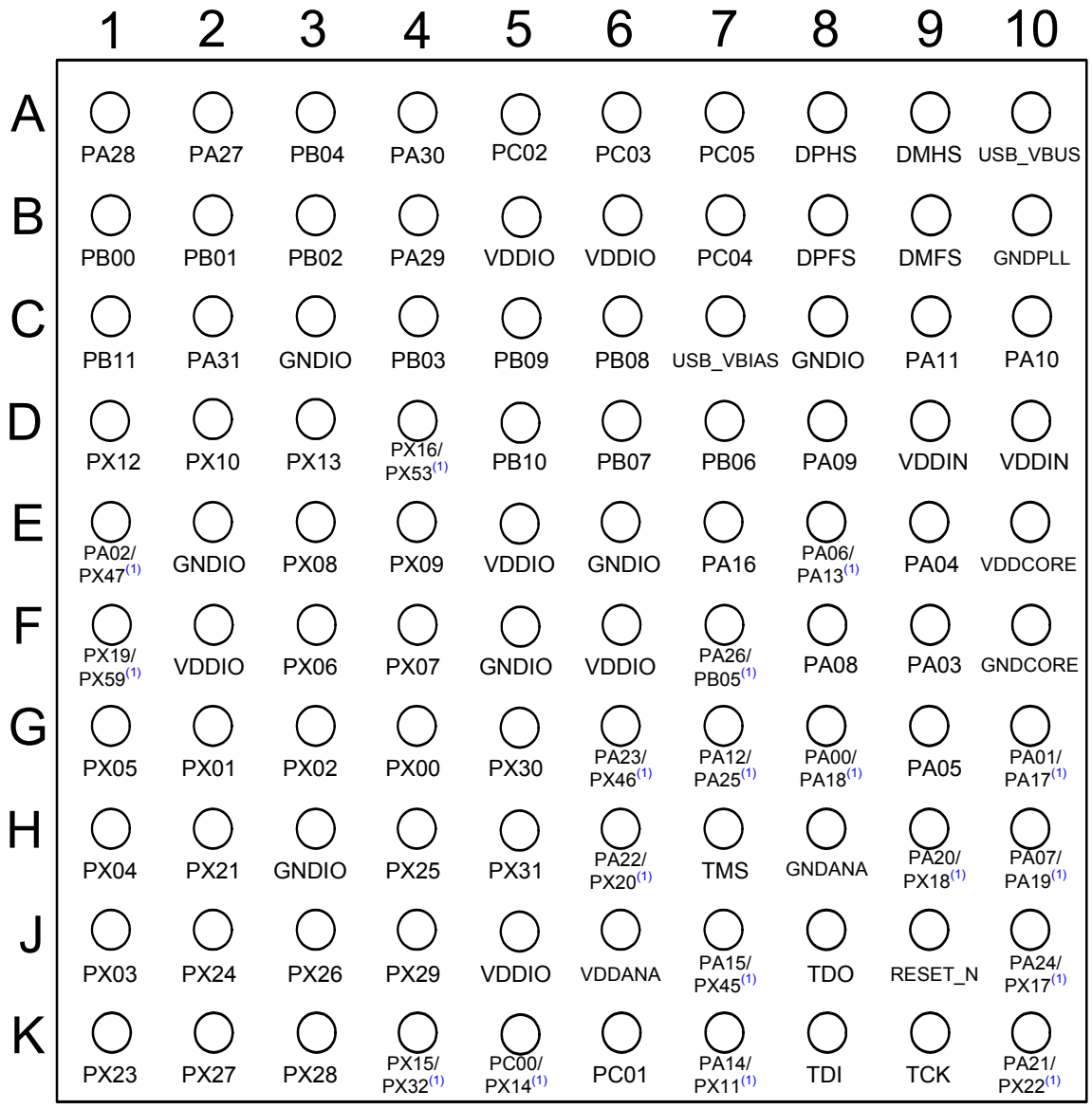


Figure 3-3. VFBGA100 Pinout (top view)



Note: 1. Those balls are physically connected to 2 GPIOs. Software must managed carrefully the GPIO configuration to avoid electrical conflict

Table 3-6. Signal Description List

Signal Name	Function	Type	Active Level	Comments
RESET_N	Reset Pin	Input	Low	
DMA Controller - DMACA (optional)				
DMAACK[1:0]	DMA Acknowledge	Output		
DMARQ[1:0]	DMA Requests	Input		
External Interrupt Controller - EIC				
EXTINT[7:0]	External Interrupt Pins	Input		
SCAN[7:0]	Keypad Scan Pins	Output		
NMI	Non-Maskable Interrupt Pin	Input	Low	
General Purpose Input/Output pin - GPIOA, GPIOB, GPIOC, GPIOX				
PA[31:0]	Parallel I/O Controller GPIO port A	I/O		
PB[11:0]	Parallel I/O Controller GPIO port B	I/O		
PC[5:0]	Parallel I/O Controller GPIO port C	I/O		
PX[59:0]	Parallel I/O Controller GPIO port X	I/O		
External Bus Interface - EBI				
ADDR[23:0]	Address Bus	Output		
CAS	Column Signal	Output	Low	
CFCE1	Compact Flash 1 Chip Enable	Output	Low	
CFCE2	Compact Flash 2 Chip Enable	Output	Low	
CFRNW	Compact Flash Read Not Write	Output		
DATA[15:0]	Data Bus	I/O		
NANDOE	NAND Flash Output Enable	Output	Low	
NANDWE	NAND Flash Write Enable	Output	Low	
NCS[5:0]	Chip Select	Output	Low	
NRD	Read Signal	Output	Low	
NWAIT	External Wait Signal	Input	Low	
NWE0	Write Enable 0	Output	Low	
NWE1	Write Enable 1	Output	Low	
RAS	Row Signal	Output	Low	

Table 5-1. AT32UC3A3A4 Physical Memory Map

Device	Start Address	Size AT32UC3A3256S AT32UC3A3256 AT32UC3A4256S AT32UC3A4256	Size AT32UC3A3128S AT32UC3A3128 AT32UC3A4128S AT32UC3A4128	Size AT32UC3A364S AT32UC3A364 AT32UC3A464S AT32UC3A464
HRAMC0	0xFF000000	32KByte	32KByte	32KByte
HRAMC1	0xFF008000	32KByte	32KByte	32KByte
HSB-PB Bridge A	0xFFFF0000	64KByte	64KByte	64KByte
HSB-PB Bridge B	0xFFFE0000	64KByte	64KByte	64KByte

5.3 Peripheral Address Map

Table 5-2. Peripheral Address Mapping

Address		Peripheral Name
0xFF100000	DMACA	DMA Controller - DMACA
0xFFFD0000	AES	Advanced Encryption Standard - AES
0xFFFE0000	USB	USB 2.0 Device and Host Interface - USB
0xFFFE1000	HMATRIX	HSB Matrix - HMATRIX
0xFFFE1400	FLASHC	Flash Controller - FLASHC
0xFFFE1C00	SMC	Static Memory Controller - SMC
0xFFFE2000	SDRAMC	SDRAM Controller - SDRAMC
0xFFFE2400	ECCHRS	Error code corrector Hamming and Reed Solomon - ECCHRS
0xFFFE2800	BUSMON	Bus Monitor module - BUSMON
0xFFFE4000	MCI	Mulitmedia Card Interface - MCI
0xFFFE8000	MSI	Memory Stick Interface - MSI
0xFFFF0000	PDCA	Peripheral DMA Controller - PDCA
0xFFFF0800	INTC	Interrupt controller - INTC

Table 5-3. Local Bus Mapped GPIO Registers

Port	Register	Mode	Local Bus Address	Access
2	Output Driver Enable Register (ODER)	WRITE	0x40000240	Write-only
		SET	0x40000244	Write-only
		CLEAR	0x40000248	Write-only
		TOGGLE	0x4000024C	Write-only
	Output Value Register (OVR)	WRITE	0x40000250	Write-only
		SET	0x40000254	Write-only
		CLEAR	0x40000258	Write-only
		TOGGLE	0x4000025C	Write-only
	Pin Value Register (PVR)	-	0x40000260	Read-only
3	Output Driver Enable Register (ODER)	WRITE	0x40000340	Write-only
		SET	0x40000344	Write-only
		CLEAR	0x40000348	Write-only
		TOGGLE	0x4000034C	Write-only
	Output Value Register (OVR)	WRITE	0x40000350	Write-only
		SET	0x40000354	Write-only
		CLEAR	0x40000358	Write-only
		TOGGLE	0x4000035C	Write-only
	Pin Value Register (PVR)	-	0x40000360	Read-only

7.2.1 I/O Pin Output Level Typical Characteristics

Figure 7-1. I/O Pin drive x2 Output Low Level Voltage (VOL) vs. Source Current

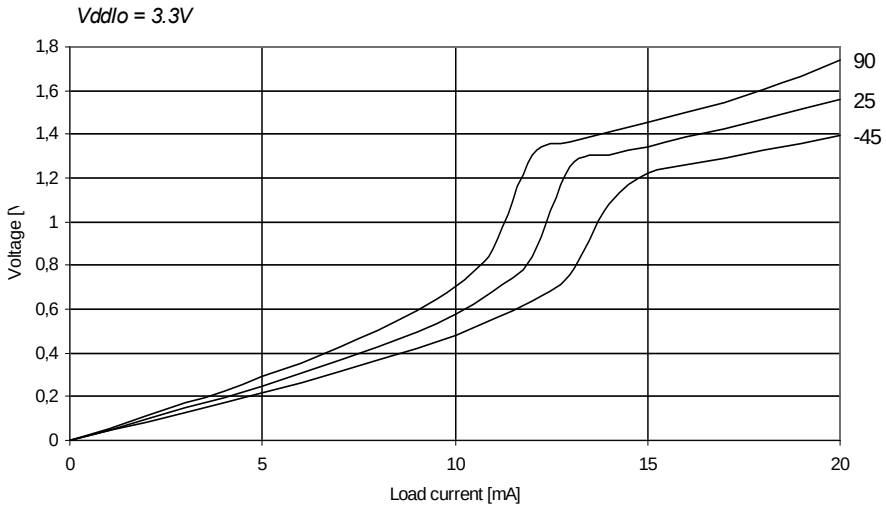
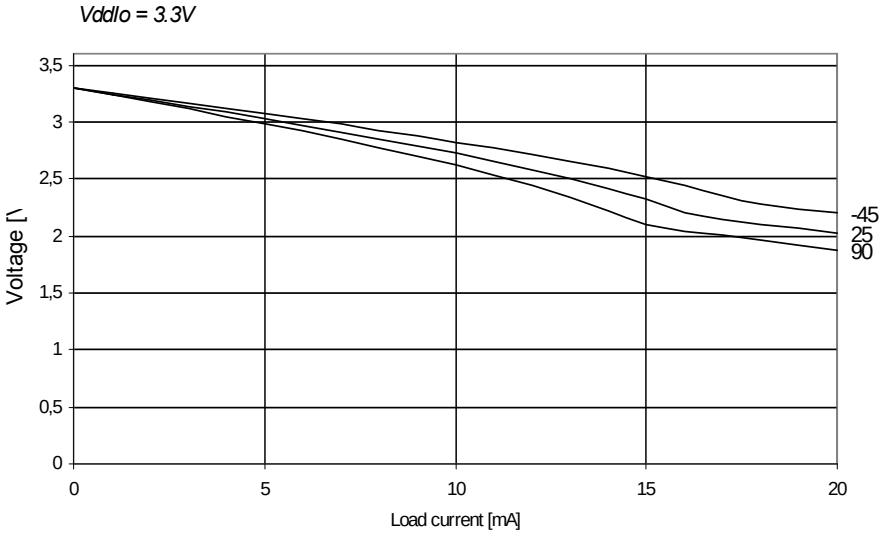


Figure 7-2. I/O Pin drive x2 Output High Level Voltage (VOH) vs. Source Current



7.3 I/O pin Characteristics

These parameters are given in the following conditions:

- V_{DDCORE} = 1.8V
- V_{DDIO} = 3.3V
- Ambient Temperature = 25°C

Table 7-9. BOD Timing

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
T_{BOD}	Minimum time with VDDCORE < VBOD to detect power failure	Falling VDDCORE from 1.8V to 1.1V		300	800	ns

7.5.3 Reset Sequence

Table 7-10. Electrical Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DDRR}	VDDIN/VDDIO rise rate to ensure power-on-reset		0.8			V/ms
V_{POR+}	Rising threshold voltage: voltage up to which device is kept under reset by POR on rising VDDIN	Rising VDDIN: $V_{RESTART}$ -> V_{POR+}		2.7		V
V_{POR-}	Falling threshold voltage: voltage when POR resets device on falling VDDIN	Falling VDDIN: 3.3V -> V_{POR-}		2.7		V
$V_{RESTART}$	On falling VDDIN, voltage must go down to this value before supply can rise again to ensure reset signal is released at V_{POR+}	Falling VDDIN: 3.3V -> $V_{RESTART}$			0.2	V
T_{SSU1}	Time for Cold System Startup: Time for CPU to fetch its first instruction (RCosc not calibrated)		480		960	µs
T_{SSU2}	Time for Hot System Startup: Time for CPU to fetch its first instruction (RCosc calibrated)			420		µs

Figure 7-3. MCU Cold Start-Up

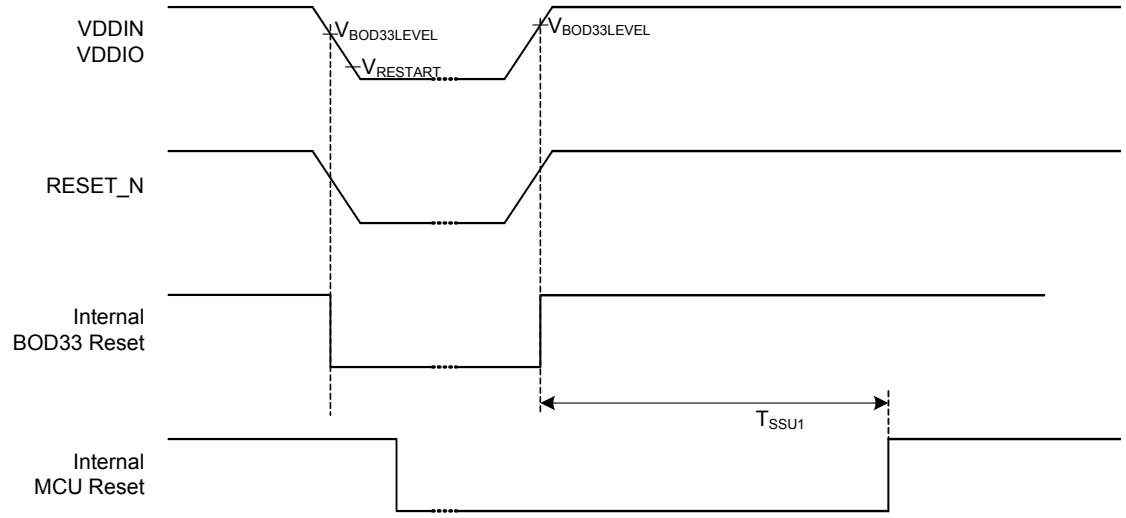


Figure 7-4. MCU Cold Start-Up RESET_N Externally Driven

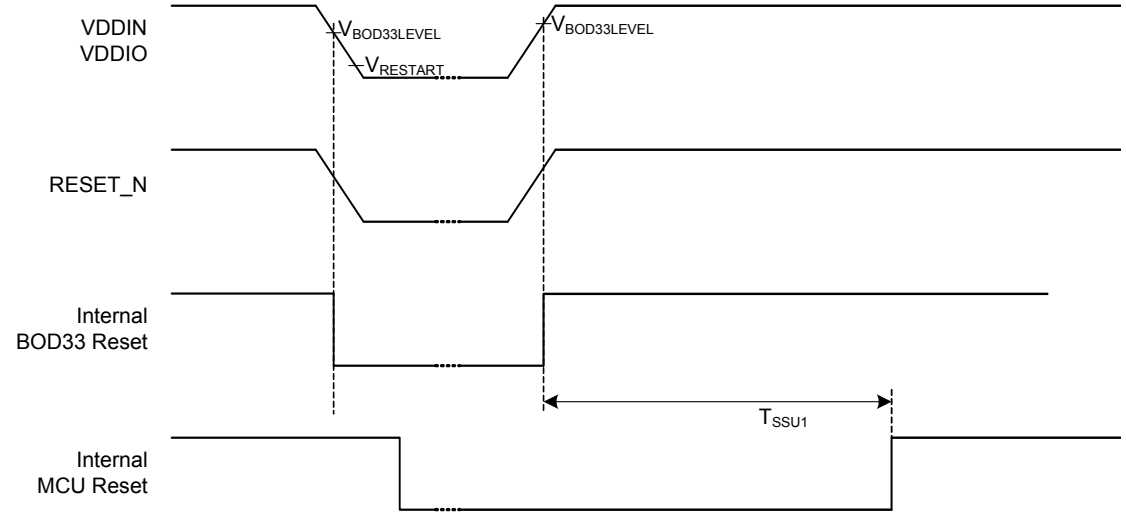


Figure 7-5. MCU Hot Start-Up

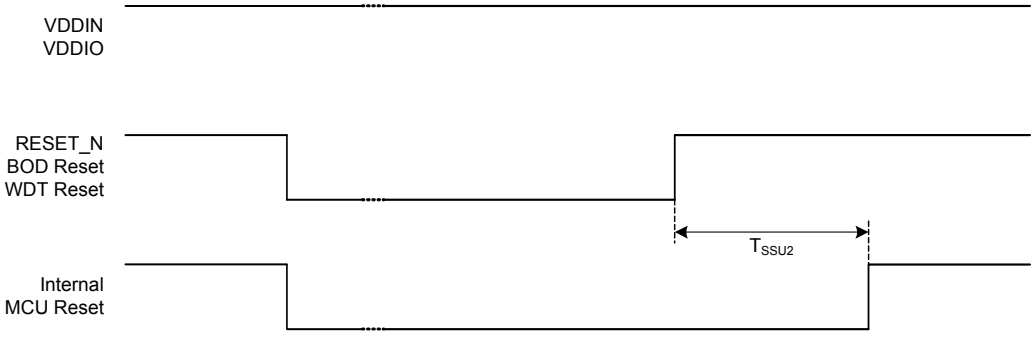


Table 7-13. Typical Cuurent Consumption by Peripheral

Peripheral	Typ.	Unit
ADC	7	µA/MHz
AES	80	
ABDAC	10	
DMACA	70	
EBI	23	
EIC	0.5	
GPIO	37	
INTC	3	
MCI	40	
MSI	10	
PDCA	20	
SDRAM	5	
SMC	9	
SPI	6	
SSC	10	
RTC	5	
TC	8	
TWIM	2	
TWIS	2	
USART	10	
USBB	90	
WDT	2	

7.8 Oscillator Characteristics

The following characteristics are applicable to the operating temperature range: T_A = -40°C to 85°C and worst case of power supply, unless otherwise specified.

7.8.1 Slow Clock RC Oscillator

Table 7-17. RC Oscillator Frequency

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
F_{RC}	RC Oscillator Frequency	Calibration point: T_A = 85°C		115.2	116	KHz
		T_A = 25°C		112		KHz
		T_A = -40°C	105	108		KHz

7.8.2 32 KHz Oscillator

Table 7-18. 32 KHz Oscillator Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$1/(t_{CP32KHz})$	Oscillator Frequency	External clock on XIN32			30	MHz
		Crystal		32 768		Hz
C_L	Equivalent Load Capacitance		6		12.5	pF
ESR	Crystal Equivalent Series Resistance				100	KΩ
t_{ST}	Startup Time	C_L = 6pF(1) C_L = 12.5pF(1)			600 1200	ms
t_{CH}	XIN32 Clock High Half-period		0.4 t_{CP}		0.6 t_{CP}	
t_{CL}	XIN32 Clock Low Half-period		0.4 t_{CP}		0.6 t_{CP}	
C_{IN}	XIN32 Input Capacitance				5	pF
I_{OSC}	Current Consumption	Active mode			1.8	µA
		Standby mode			0.1	µA

Note: 1. C_L is the equivalent load capacitance.

7.9 ADC Characteristics

Table 7-22. Channel Conversion Time and ADC Clock

Parameter	Conditions	Min.	Typ.	Max.	Unit
ADC Clock Frequency	10-bit resolution mode			5	MHz
	8-bit resolution mode			8	MHz
Startup Time	Return from Idle Mode			20	µs
Track and Hold Acquisition Time		600			ns
Conversion Time	ADC Clock = 5 MHz			2	µs
	ADC Clock = 8 MHz			1.25	µs
Throughput Rate	ADC Clock = 5 MHz			384 (1)	kSPS
	ADC Clock = 8 MHz			533 (2)	kSPS

1. Corresponds to 13 clock cycles: 3 clock cycles for track and hold acquisition time and 10 clock cycles for conversion.
2. Corresponds to 15 clock cycles: 5 clock cycles for track and hold acquisition time and 10 clock cycles for conversion.

Table 7-23. ADC Power Consumption

Parameter	Conditions	Min.	Typ.	Max.	Unit
Current Consumption on VDDANA (1)	On 13 samples with ADC clock = 5 MHz			1.25	mA

1. Including internal reference input current

Table 7-24. Analog Inputs

Parameter	Conditions	Min.	Typ.	Max.	Unit
Input Voltage Range		0		VDDANA	V
Input Leakage Current				1	µA
Input Capacitance			7		pF
Input Resistance			350	850	Ohm

Table 7-25. Transfer Characteristics in 8-bit mode

Parameter	Conditions	Min.	Typ.	Max.	Unit
Resolution			8		Bit
Absolute Accuracy	ADC Clock = 5 MHz			0.8	LSB
	ADC Clock = 8 MHz			1.5	LSB
Integral Non-linearity	ADC Clock = 5 MHz		0.35	0.5	LSB
	ADC Clock = 8 MHz		0.5	1.5	LSB
Differential Non-linearity	ADC Clock = 5 MHz		0.3	0.5	LSB
	ADC Clock = 8 MHz		0.5	1.5	LSB
Offset Error	ADC Clock = 5 MHz	-1.5		1.5	LSB
Gain Error	ADC Clock = 5 MHz	-0.5		0.5	LSB

Table 7-32. SMC Read Signals with no Hold Settings

Symbol	Parameter	Min.	Unit
NRD Controlled (READ_MODE = 1)			
SMC_{19}	Data Setup before NRD High	13.7	ns
SMC_{20}	Data Hold after NRD High	1	ns
NRD Controlled (READ_MODE = 0)			
SMC_{21}	Data Setup before NCS High	13.3	ns
SMC_{22}	Data Hold after NCS High	0	ns

Table 7-33. SMC Write Signals with Hold Settings

Symbol	Parameter	Min.	Unit
NRD Controlled (READ_MODE = 1)			
SMC_{23}	Data Out Valid before NWE High	(nwe pulse length - 1) * t_{CPSMC} - 0.9	ns
SMC_{24}	Data Out Valid after NWE High(1)	nwe hold length * t_{CPSMC} - 6	ns
SMC_{25}	NWE High to NBS0/A0 Change(1)	nwe hold length * t_{CPSMC} - 1.9	ns
SMC_{26}	NWE High to NBS1 Change(1)	nwe hold length * t_{CPSMC} - 1.9	ns
SMC_{29}	NWE High to A1 Change(1)	nwe hold length * t_{CPSMC} - 1.9	ns
SMC_{31}	NWE High to A2 - A23 Change(1)	nwe hold length * t_{CPSMC} - 1.7	ns
SMC_{32}	NWE High to NCS Inactive(1)	(nwe hold length - ncs wr hold length)* t_{CPSMC} - 2.9	ns
SMC_{33}	NWE Pulse Width	nwe pulse length * t_{CPSMC} - 0.9	ns
NRD Controlled (READ_MODE = 0)			
SMC_{34}	Data Out Valid before NCS High	(ncs wr pulse length - 1)* t_{CPSMC} - 4.6	ns
SMC_{35}	Data Out Valid after NCS High(1)	ncs wr hold length * t_{CPSMC} - 5.8	ns
SMC_{36}	NCS High to NWE Inactive(1)	(ncs wr hold length - nwe hold length)* t_{CPSMC} - 0.6	ns

Note: 1. hold length = total cycle duration - setup duration - pulse duration. “hold length” is for “ncs wr hold length” or “nwe hold length"

Table 7-34. SMC Write Signals with No Hold Settings (NWE Controlled only)

Symbol	Parameter	Min.	Unit
SMC_{37}	NWE Rising to A2-A25 Valid	5.4	ns
SMC_{38}	NWE Rising to NBS0/A0 Valid	5	ns
SMC_{39}	NWE Rising to NBS1 Change	5	ns
SMC_{40}	NWE Rising to A1/NBS2 Change	5	ns
SMC_{41}	NWE Rising to NBS3 Change	5	ns
SMC_{42}	NWE Rising to NCS Rising	5.1	ns

Table 7-36. SDRAM Clock Signal

Symbol	Parameter	Conditions	Min.	Max.	Unit
$SDRAMC_{13}$	Bank Change before SDCK Rising Edge		6.3		ns
$SDRAMC_{14}$	Bank Change after SDCK Rising Edge		2.4		ns
$SDRAMC_{15}$	CAS Low before SDCK Rising Edge		7.4		ns
$SDRAMC_{16}$	CAS High after SDCK Rising Edge		1.9		ns
$SDRAMC_{17}$	DQM Change before SDCK Rising Edge		6.4		ns
$SDRAMC_{18}$	DQM Change after SDCK Rising Edge		2.2		ns
$SDRAMC_{19}$	D0-D15 in Setup before SDCK Rising Edge		9		ns
$SDRAMC_{20}$	D0-D15 in Hold after SDCK Rising Edge		0		ns
$SDRAMC_{23}$	SDWE Low before SDCK Rising Edge		7.6		ns
$SDRAMC_{24}$	SDWE High after SDCK Rising Edge		1.8		ns
$SDRAMC_{25}$	D0-D15 Out Valid before SDCK Rising Edge		7.1		ns
$SDRAMC_{26}$	D0-D15 Out Valid after SDCK Rising Edge		1.5		ns

9. Ordering Information

Device	Ordering Code	Package	Conditioning	Temperature Operating Range
AT32UC3A3256S	AT32UC3A3256S-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3256S-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A3256S-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3256S-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A3256	AT32UC3A3256-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3256-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A3256-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3256-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A3128S	AT32UC3A3128S-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3128S-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A3128S-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3128S-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A3128	AT32UC3A3128-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3128-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A3128-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A3128-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A364S	AT32UC3A364S-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A364S-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A364S-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A364S-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A364	AT32UC3A364-ALUT	144-lead LQFP	Tray	Industrial (-40·C to 85·C)
	AT32UC3A364-ALUR	144-lead LQFP	Reels	Industrial (-40·C to 85·C)
	AT32UC3A364-CTUT	144-ball TFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A364-CTUR	144-ball TFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A4256S	AT32UC3A4256S-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A4256S-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A4256	AT32UC3A4256-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A4256-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A4128S	AT32UC3A4128S-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A4128S-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A4128	AT32UC3A4128-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A4128-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A464S	AT32UC3A464S-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A464S-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)
AT32UC3A464	AT32UC3A464-C1UT	100-ball VFBGA	Tray	Industrial (-40·C to 85·C)
	AT32UC3A464-C1UR	100-ball VFBGA	Reels	Industrial (-40·C to 85·C)

Fix/Workaround
Set to 1b bit CORRS4 of the ECCHRS mode register (MD). In C-code: *((volatile int*) (0xFFFE2404))= 0x400.

DMACA data transfer fails when CTLx.SRC_TR_WIDTH is not equal to CTLx.DST_TR_WIDTH
Fix/Workaround
For any DMACA transfer make sure CTLx.SRC_TR_WIDTH = CTLx.DST_TR_WIDTH.

3.3V supply monitor is not available
FGPFRLO[30:29] are reserved and should not be used by the application.
Fix/Workaround
None.

Service access bus (SAB) can not access DMACA registers
Fix/Workaround
None.

10.2.2 Processor and Architecture

LDM instruction with PC in the register list and without ++ increments Rp
For LDM with PC in the register list: the instruction behaves as if the ++ field is always set, ie the pointer is always updated. This happens even if the ++ field is cleared. Specifically, the increment of the pointer is done in parallel with the testing of R12.
Fix/Workaround
None.

Hardware breakpoints may corrupt MAC results
Hardware breakpoints on MAC instructions may corrupt the destination register of the MAC instruction.
Fix/Workaround
Place breakpoints on earlier or later instructions.

When the main clock is RCSYS, TIMER_CLOCK5 is equal to PBA clock
When the main clock is generated from RCSYS, TIMER_CLOCK5 is equal to PBA Clock and not PBA Clock / 128.
Fix/Workaround
None.

10.2.3 MPU

Privilege violation when using interrupts in application mode with protected system stack
If the system stack is protected by the MPU and an interrupt occurs in application mode, an MPU DTLB exception will occur.
Fix/Workaround
Make a DTLB Protection (Write) exception handler which permits the interrupt request to be handled in privileged mode.

10.2.4 USB

UPCFGn.INTFRQ is irrelevant for isochronous pipe
As a consequence, isochronous IN and OUT tokens are sent every 1ms (Full Speed), or every 125uS (High Speed).

Fix/Workaround
Before going to sleep modes where the system RC oscillator is stopped, make sure that the factor between the CPU/HSB and PBx frequencies is less than or equal to 4.

10.2.9 PDCA

PCONTROL.CHxRES is non-functional
PCONTROL.CHxRES is non-functional. Counters are reset at power-on, and cannot be reset by software.
Fix/Workaround
Software needs to keep history of performance counters.

Transfer error will stall a transmit peripheral handshake interface
If a transfer error is encountered on a channel transmitting to a peripheral, the peripheral handshake of the active channel will stall and the PDCA will not do any more transfers on the affected peripheral handshake interface.
Fix/Workaround
Disable and then enable the peripheral after the transfer error.

10.2.10 AES

URAD (Unspecified Register Access Detection Status) does not detect read accesses to the write-only KEYW[5..8]R registers
Fix/Workaround
None.

10.2.11 HMATRIX

In the PRAS and PRBS registers, the MxPR fields are only two bits
In the PRAS and PRBS registers, the MxPR fields are only two bits wide, instead of four bits. The unused bits are undefined when reading the registers.
Fix/Workaround
Mask undefined bits when reading PRAS and PRBS.

10.2.12 TWIM

TWIM SR.IDLE goes high immediately when NAK is received
When a NAK is received and there is a non-zero number of bytes to be transmitted, SR.IDLE goes high immediately and does not wait for the STOP condition to be sent. This does not cause any problem just by itself, but can cause a problem if software waits for SR.IDLE to go high and then immediately disables the TWIM by writing a one to CR.MDIS. Disabling the TWIM causes the TWCK and TWD pins to go high immediately, so the STOP condition will not be transmitted correctly.
Fix/Workaround
If possible, do not disable the TWIM. If it is absolutely necessary to disable the TWIM, there must be a software delay of at least two TWCK periods between the detection of SR.IDLE==1 and the disabling of the TWIM.

TWIM TWALM polarity is wrong
The TWALM signal in the TWIM is active high instead of active low.
Fix/Workaround
Use an external inverter to invert the signal going into the TWIM. When using both TWIM and TWIS on the same pins, the TWALM cannot be used.

SMBALERT bit may be set after reset
The SMBus Alert (SMBALERT) bit in the Status Register (SR) might be erroneously set after system reset.
Fix/Workaround
After system reset, clear the SR.SMBALERT bit before commencing any TWI transfer.

10.2.13 TWIS

Clearing the NAK bit before the BTF bit is set locks up the TWI bus
When the TWIS is in transmit mode, clearing the NAK Received (NAK) bit of the Status Register (SR) before the end of the Acknowledge/Not Acknowledge cycle will cause the TWIS to attempt to continue transmitting data, thus locking up the bus.
Fix/Workaround
Clear SR.NAK only after the Byte Transfer Finished (BTF) bit of the same register has been set.

TWIS stretch on Address match error
When the TWIS stretches TWCK due to a slave address match, it also holds TWD low for the same duration if it is to be receiving data. When TWIS releases TWCK, it releases TWD at the same time. This can cause a TWI timing violation.
Fix/Workaround
None.

10.2.14 MCI

MCI_CLK features is not available on PX12, PX13 and PX40
Fix/Workaround
MCI_CLK feature is available on PA27 only.

The busy signal of the responses R1b is not taken in account for CMD12 STOP_TRANSFER
It is not possible to know the busy status of the card during the response (R1b) for the commands CMD12.
Fix/Workaround
The card busy line should be polled through the GPIO Input Value register (IVR) for commands CMD12.

10.2.15 SSC

Frame Synchro and Frame Synchro Data are delayed by one clock cycle
The frame synchro and the frame synchro data are delayed from 1 SSC_CLOCK when:
- Clock is CKDIV
- The START is selected on either a frame synchro edge or a level
- Frame synchro data is enabled
- Transmit clock is gated on output (through CKO field)

Fix/Workaround
Transmit or receive CLOCK must not be gated (by the mean of CKO field) when START condition is performed on a generated frame synchro.

10.2.16 FLASHC

Corrupted read in flash may happen after fuses write or erase operations (FLASHC LP, UP, WGPB, EGPB, SSB, PGPFB, EAGPF commands)
After a flash fuse write or erase operation (FLASHC LP, UP, WGPB, EGPB, SSB, PGPFB, EAGPF commands), reading (data read or code fetch) in flash may fail. This may lead to an exception or to other errors derived from this corrupted read access.
Fix/Workaround
Before the flash fuse write or erase operation, enable the flash high speed mode (FLASHC HSEN command). The flash fuse write or erase operations (FLASHC LP, UP, WGPB, EGPB, SSB, PGPFB, EAGPF commands) must be issued from RAM or through the EBI. After these commands, read 3 times one flash page initialized to 00h. Disable the flash high speed mode (FLASHC HSDIS command). It is then possible to safely read or code fetch the flash.

10.3 Rev. D

10.3.1 General

Devices cannot operate with CPU frequency higher than 66MHz in 1WS and 36MHz in 0WS
Fix/Workaround
None

DMACA data transfer fails when CTLx.SRC_TR_WIDTH is not equal to CTLx.DST_TR_WIDTH
Fix/Workaround
For any DMACA transfer make sure CTLx.SRC_TR_WIDTH = CTLx.DST_TR_WIDTH.

3.3V supply monitor is not available
FGPFRLO[30:29] are reserved and should not be used by the application.
Fix/Workaround
None.

Service access bus (SAB) can not access DMACA registers
Fix/Workaround
None.

10.3.2 Processor and Architecture

LDM instruction with PC in the register list and without ++ increments Rp
For LDM with PC in the register list: the instruction behaves as if the ++ field is always set, ie the pointer is always updated. This happens even if the ++ field is cleared. Specifically, the increment of the pointer is done in parallel with the testing of R12.
Fix/Workaround
None.

Hardware breakpoints may corrupt MAC results
Hardware breakpoints on MAC instructions may corrupt the destination register of the MAC instruction.
Fix/Workaround
Place breakpoints on earlier or later instructions.

Fix/Workaround
None.

10.3.14 MCI

The busy signal of the responses R1b is not taken in account for CMD12 STOP_TRANSFER
It is not possible to know the busy status of the card during the response (R1b) for the commands CMD12.
Fix/Workaround
The card busy line should be polled through the GPIO Input Value register (IVR) for commands CMD12.

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